

Springer
Handbook *of*

Crystal
Growth



*Dhanaraj
Byrappa
Prasad
Dudley
Editors*

**Springer Handbook
of Crystal Growth**

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Springer Handbook of Crystal Growth

Govindhan Dhanaraj, Kullaiah Byrappa,
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With DVD-ROM, 1320 Figures, 134 in four color and 124 Tables



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Preface

Over the years, many successful attempts have been made to describe the art and science of crystal growth, and many review articles, monographs, symposium volumes, and handbooks have been published to present comprehensive reviews of the advances made in this field. These publications are testament to the growing interest in both bulk and thin-film crystals because of their electronic, optical, mechanical, microstructural, and other properties, and their diverse scientific and technological applications. Indeed, most modern advances in semiconductor and optical devices would not have been possible without the development of many elemental, binary, ternary, and other compound crystals of varying properties and large sizes. The literature devoted to basic understanding of growth mechanisms, defect formation, and growth processes as well as the design of growth systems is therefore vast.

The objective of this Springer Handbook is to present the state of the art of selected topical areas of both bulk and thin-film crystal growth. Our goal is to make readers understand the basics of the commonly employed growth processes, materials produced, and defects generated. To accomplish this, we have selected more than 50 leading scientists, researchers, and engineers, and their many collaborators from 22 different countries, to write chapters on the topics of their expertise. These authors have written 52 chapters on the fundamentals of crystal growth and defect formation; bulk growth from the melt, solution, and vapor; epitaxial growth; modeling of growth processes and defects; and techniques of defect characterization, as well as some contemporary special topics.

This Springer Handbook is divided into seven parts. Part A presents the fundamentals: an overview of the growth and characterization techniques, followed by the state of the art of nucleation at surfaces, morphology of crystals grown from solutions, nucleation of dislocation during growth, and defect formation and morphology.

Part B is devoted to bulk growth from the melt, a method critical to producing large-size crystals. The

chapters in this part describe the well-known processes such as Czochralski, Kyropoulos, Bridgman, and floating zone, and focus specifically on recent advances in improving these methodologies such as application of magnetic fields, orientation of the growth axis, introduction of a pedestal, and shaped growth. They also cover a wide range of materials from silicon and III–V compounds to oxides and fluorides.

The third part, Part C of the book, focuses on solution growth. The various aspects of hydrothermal growth are discussed in two chapters, while three other chapters present an overview of the nonlinear and laser crystals, *KTP* and *KDP*. The knowledge on the effect of gravity on solution growth is presented through a comparison of growth on Earth versus in a microgravity environment.

The topic of Part D is vapor growth. In addition to presenting an overview of vapor growth, this part also provides details on vapor growth of silicon carbide, gallium nitride, aluminum nitride, and organic semiconductors. This is followed by chapters on epitaxial growth and thin films in Part E. The topics range from chemical vapor deposition to liquid-phase epitaxy to pulsed laser and pulsed electron deposition.

Modeling of both growth processes and defect formation is presented in Part F. These chapters demonstrate the direct correlation between the process parameters and quality of the crystal produced, including the formation of defects. The subsequent Part G presents the techniques that have been developed for crystalline material characterization and analysis. The chapters in Parts F and G demonstrate how well predictive tools and analytical techniques have helped the design and control of growth processes for better-quality crystals of large sizes.

The final Part H is devoted to some selected contemporary topics in this field, such as protein crystal growth, crystallization from gels, in situ structural studies, growth of single-crystal scintillation materials, photovoltaic materials, and wire-saw slicing of large crystals to produce wafers.

We hope this Springer Handbook will be useful to graduate students studying crystal growth and to re-

searchers, scientists, and engineers from academia and industry who are conducting or intend to conduct research in this field as well as those who grow crystals.

We would like to express our sincere thanks to Dr. Claus Acheron and Dr. Werner Skolaut of Springer and Ms Anne Strohbach of le-tex for their extraordinary efforts without which this handbook would not have taken its final shape.

We thank our authors for writing comprehensive chapters and having patience with us during the publication of this Handbook. One of the editors (GD) would

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Kullaiiah Byrappa received his Doctor's degree in Crystal Growth from the Moscow State University, Moscow in 1981. He is Professor of Materials Science, Head of the Crystal Growth Laboratory, and Director of the Internal Quality Assurance Cell of the University of Mysore, India. His current research is in crystal engineering of polyscale materials through novel solution processing routes, particularly covering hydrothermal, solvothermal and supercritical methods. Professor Byrappa has co-authored the Handbook of Hydrothermal Technology, and edited 4 books as well as two special editions of Journal of Materials Science, and published 180 research papers including 26 invited reviews and book chapters on various aspects of novel routes of solution processing. Professor Byrappa has delivered over 60 keynote and invited lectures at International Conferences, and several hundreds of colloquia and seminars at various institutions around the world. He has also served as chair and co-chair for numerous international conferences. He is a Fellow of the World Academy of Ceramics. Professor Byrappa is serving in several international committees and commissions related to crystallography, crystal growth, and materials science. He is the Founder Secretary of the International Solvothermal and Hydrothermal Association. Professor Byrappa is a recipient of several awards such as the Sir C.V. Raman Award, Materials Research Society of India Medal, and the Golden Jubilee Award of the University of Mysore.



Vishwanath "Vish" Prasad is the Vice President for Research and Economic Development and Professor of Mechanical and Energy Engineering at the University of North Texas (UNT), one of the largest university in the state of Texas. He received his PhD from the University of Delaware (USA), his Masters of Technology from the Indian Institute of Technology, Kanpur, and his bachelor's from Patna University in India all in Mechanical Engineering. Prior to joining UNT in 2007, Dr. Prasad served as the Dean at Florida International University (FIU) in Miami, where he also held the position of Distinguished Professor of Engineering. Previously, he has served as a Leading Professor of Mechanical Engineering at Stony Brook University, New York, as an Associate Professor and Assistant Professor at Columbia University. He has received many special recognitions for his contributions to engineering education. Dr. Prasad's research interests include thermo-fluid sciences, energy systems, electronic materials, and computational materials processing. He has published over 200 articles, edited/co-edited several books and organized numerous conferences, symposia, and workshops. He serves as the lead editor of the Annual Review of Heat Transfer. In the past, he has served as an Associate Editor of the ASME Journal of Heat. Dr. Prasad is an elected Fellow of the American Society of Mechanical Engineers (ASME), and has served as a member of the USRA Microgravity Research Council. Dr. Prasad's research has focused on bulk growth of silicon, III-V compounds, and silicon carbide; growth of large diameter Si tube; design of crystal growth systems; and sputtering and chemical vapor deposition of thin films. He is also credited to initiate research on wire saw cutting of large crystals to produce wafers with much reduced material loss. Dr. Prasad's research has been well funded by US National Science Foundation (NSF), US Department of Defense, US Department of Energy, and industry.



Michael Dudley received his Doctoral Degree in Engineering from Warwick University, UK, in 1982. He is Professor and Chair of the Materials Science and Engineering Department at Stony Brook University, New York, USA. He is director of the Stony Brook Synchrotron Topography Facility at the National Synchrotron Light Source at Brookhaven National Laboratory, Upton New York. His current research focuses on crystal growth and characterization of defect structures in single crystals with a view to determining their origins. The primary technique used is synchrotron topography which enables analysis of defects and generalized strain fields in single crystals in general, with particular emphasis on semiconductor, optoelectronic, and optical crystals. Establishing the relationship between crystal growth conditions and resulting defect distributions is a particular thrust area of interest to Dudley, as is the correlation between electronic/optoelectronic device performance and defect distribution. Other techniques routinely used in such analysis include transmission electron microscopy, high resolution triple-axis x-ray diffraction, atomic force microscopy, scanning electron microscopy, Nomarski optical microscopy, conventional optical microscopy, IR microscopy and fluorescent laser scanning confocal microscopy. Dudley's group has played a prominent role in the development of SiC and AlN growth, characterizing crystals grown by many of the academic and commercial entities involved enabling optimization of crystal quality. He has co-authored some 315 refereed articles and 12 book chapters, and has edited 5 books. He is currently a member of the Editorial Board of Journal of Applied Physics and Applied Physics Letters and has served as Chair or Co-Chair for numerous international conferences.



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